## PATENT APPLICATION

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	
MITSUTOSHI HASEGAWA ET AL Application No.: 10/647,287	<ul><li>Examiner: Not Yet Assigned</li><li>Group Art Unit: Not Yet Assigned</li></ul>
Filed: August 26, 2003	: )
For: ENVELOPE, ENVELOPE MANUFACTURING METHOD, IMAGE DISPLAY DEVICE, AND TELEVISION DISPLAY DEVICE	: ) : January 13, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## **INFORMATION DISCLOSURE STATEMENT**

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. In accordance with OG Notice August 5, 2003, Applicants waive the requirement under 37 CFR 1.98 for submitting a copy of each cited U.S. patent and each U.S. patent application publication, since the present application was filed after June 30, 2003. However, if the Examiner wishes Applicants to supply any such copies, Applicants will gladly do so upon request.

For the concise explanation of relevance for non-English document, 7-326311, the Examiner is respectfully referred to the English Abstract attached thereto;

for the concise statement of relevance for non-English document 8-185818, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Nos. 6,137,218 and 6,283,813;

for the concise statement of relevance for non-English document 9-50757, the Examiner is respectfully referred to the English Abstract attached thereto;

for the concise statement of relevance for non-English document 9-102271, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent 6,296,896;

for the concise statement of relevance for non-English document 2000-251665, the Examiner is respectfully referred to the English Abstract attached thereto;

for the concise statement of relevance for non-English document 64-031332, the Examiner is respectfully referred to the English Abstract attached thereto, and to the present application at pages 1-2;

for the concise statement of relevance for non-English document 6-342636, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Nos. 5,455,597 and 5,659,329;

for the concise statement of relevance for non-English document 11-135018, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Nos. 6,254,449 and 6,506,089; and

for the concise statement of relevance for non-English document 2001-210258, the Examiner is respectfully referred to the English Abstract attached thereto and to counterpart U.S. Patent Application Publication 2002-0180342.

The Examiner's attention is also directed to the following U.S. Applications:

APPLICATION NO.	FILING DATE	GROUP ART UNIT		
10/624,637	07/23/03	n/y/a		
09/647,953	10/06/00	1762		
09/705,957	11/06/00	2882		

A copy of each cited Application is enclosed.

## **CONCLUSION**

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Registration No

FITZPATRICK, CELLA, HARPER & SCINTO

30 Rockefeller Plaza

New York, New York 10112-3800

Facsimile: (212) 218-2200

APPLICATION NO. 449 (modified) ATTY DOCKET NO. 03500.017504 10/647,287 S. DEPARTMENT OF COMMERCE ATENT AND TRADEMARK OFFICE **APPLICANTS** MITSUTOSHI HASEGAWA ET AL. AN 1 4 2015 OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) PATRADEMAN **FILING DATE GROUP** August 26, 2003 **U.S. PATENT DOCUMENTS** \*EXAMINER INITIAL DOCUMENT NUMBER DATE NAME **CLASS** 05/00 Banno et al. 6.060.113 427

		6,060,113	05/00	Banno et al.	427     125       427     77       313     493       315     169.1       345     75		
•		6,296,896 B1	10/01	Takahashi et al.			.1
		2003/0067263 A1	04/03	Tokioka et al.			
		6,624,586 B2	09/03	Abe et al.			
		5,455,597	10/95	Nakamura et al.			
		5,659,329	08/97	Yamanobe et al.	345	74	
		6,137,218	10/00	Kaneko et al.	313	495	
			FOREIG	N PATENT DOCUMENTS			
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	JP	7-326311	12/95	Japan			Abstract
	JP	8-185818	07/96	Japan	an		Abstract
	JP	9-50757	02/97	Japan			Abstract
	JP	9-102271	04/97	Japan	Japan Japan		Abstract
	JP	2000-251665	9/00	Japan			Abstract
		OTHER DO	CUMENT(S) (Incli	uding Author, Title, Date, Pertinent Pages, Etc.)			
		M. Hartwell et al, "Strong International Electron IEDM Technical Diges	Devices Me	n emission from patterned tin-ind eeting 1975, Washington, D.C., Ca 21.	lium oxid atalog N	de thin filr o. 75, CH1	ns", 023-1,
574444155							

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**EXAMINER** 

DATE CONSIDERED

n/y/a

SUBCLASS

FILING DATE IF APPROPRIATE

FORM PTO 1449 (modified)			ATTY DOCKET NO. 03500.017504	APPLICATION NO. 10/647,287			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S)		APPLICANT MITSUTOSHI HASEGAWA ET AL.					
Suse several sheets if necessary)		FILING DATE August 26,	2003	GROUP n/y/a			
Co. Co	<u> </u>		U.S. F	PATENT DOCUMENTS			
EXAMINE INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
·		6,254,449 B1	07/01	Nakanishi et al.	445	25	08/98
		6,283,813 B1	09/01	Kaneko et al.	445	24	
		2002/0180342 A1	12/02	Yamada et al.	313	493	07/02
		6,506,089 B2	01/03	Nakanishi et al.	445	25	02/01
		2003/0058192 A1	03/03	Arai et al.	345	59	09/02
			FOREIG	IN PATENT DOCUMENTS			
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	JP	64-31332	2/89	Japan			Abstract
	JP	6-342636	12/94	Japan			Abstract
	JP	11-135018	05/99	Japan			Abstract
	JPP	2001-210258	8/01	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
<u></u>							
				<del></del>			
EXAMINER				DATE CONSIDERED			

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.